# Coherence of Charge Oscillation and Emittance Compensation 

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## High-current low-emittance injectors

- Normalized emittance < ~1 mm mrad
- Peak current > 100 A
- Needed for:
- X-ray FELs
- Linear colliders
$-4^{\text {th }}$ generation SR sources (ERLs)
- Compton X-ray sources


## Emittance compensation

- Bruce Carlsten NIM A 285 (1989)
- The term
- Qualitative explanation of the phenomenon
- All the record emittance injectors use this technique
- Experimental demonstration (states of slices in a bunch): X. Qiu, K. Batchelor, I. Ben-Zvi, and X-J. Wang. Phys. Rev. Lett., 76 (1996)
- No justified analytical picture of the phenomenon
- No practically suitable analytical estimations
- A number of popular misconceptions


## Space charge or emittance?

- What dominates: space charge or emittance?

$$
\frac{I}{2 I_{0} \beta \gamma} \leftrightarrow \frac{\varepsilon_{n}^{2}}{\sigma^{2}}
$$

- Locally cold long bunch
$-\varepsilon_{T}=0$
- $\gamma=$ const
$-l y \gg \sigma$
- $\rho=$ const in a slice
- Circular symmetry
- Locally cold laminar slice
- The same assumptions except of $\rho=$ const
-     + perfect laminarity of motion


## Basic phenomena

- Longitudinal charge inhomogeneity

- Transverse charge inhomogeneity



## Principal trajectory

- Rms emittance

$$
\varepsilon_{x}=\sqrt{\left\langle x^{2}\right\rangle\left\langle x^{\prime 2}\right\rangle-\left\langle x x^{\prime}\right\rangle^{2}}
$$

- Kapchinsky - Vladimirsky equation without emittance in rms values for circular symmetrical systems

$$
\begin{aligned}
& x^{\prime \prime}+\frac{(\beta \gamma)^{\prime}}{\beta \gamma} x^{\prime}=\frac{j}{2 x}-g x \\
& j=I / I_{0}(\beta \gamma)^{3} \quad g=e G / p
\end{aligned}
$$

- The principal trajectory is a solution of this equation with given initial conditions
- The principal trajectory for another slice

$$
\propto \sqrt{j}
$$

- The linearized equation for a small dimensionless deviation from the principal trajectory $\rightarrow$ charge oscillation

$$
\begin{aligned}
& \delta^{\prime \prime}+\left(2 \frac{x^{\prime}}{x}+\frac{(\beta \gamma)^{\prime}}{\beta \gamma}\right) \delta^{\prime}=-\frac{j}{x^{2}} \delta \\
& \delta=\delta x / x
\end{aligned}
$$

- Charge oscillation phase

$$
\varphi=\arctan \left(\frac{-C^{\prime} x}{C \sqrt{j}}\right)
$$

- Conditions of emittance minima

$$
\delta^{\prime}=0 \quad \text { or } \quad \varphi=n \pi
$$

## Nonlinear phase advance

- A nonlinear equation for a small dimensionless deviation from the principal trajectory

$$
\delta^{\prime \prime}+\left(2 \frac{x^{\prime}}{x}+\frac{(\beta \gamma)^{\prime}}{\beta \gamma}\right) \delta^{\prime}+\frac{j}{x^{2}} \delta=\frac{j}{2 x^{2}}\left(\delta^{2}-\delta^{3}\right)
$$

- gives ramp phase correction

$$
\Delta \varphi \cong \frac{1}{12} \varphi a^{2}
$$

- where $a$ is the relative amplitude of charge oscillation.
- This permits to find the residual emittance and the parameters of the optimal beamline.
- If the phase portraits of adjacent slices are aligned, than more distant ones are somewhat spread due to nonlinear phase advances.

Tilts of slices in a bunch at the end of a beamline. $\zeta$ is the longitudinal coordinate in a bunch.


## Bunch motion in an optimal homogeneous beamline



$r_{0}=2, r_{0}{ }^{\prime}=0, g=0.09, j=0.032,0.065,0.13,0.18,0.25,0.5,1$. The emittance and the rms size of a Gaussian bunch.

## Bunch motion without focusing



$r_{0}=2, r_{0}{ }^{\prime}=0, g=0, j=0.032,0.065,0.13,0.18,0.25,0.5,1$. The emittance and the rms size of a Gaussian bunch.

## Transverse charge inhomogeneity

An equation for particle motion in a slice

$$
x^{\prime \prime}+\frac{(\beta \gamma)^{\prime}}{\beta \gamma} x^{\prime}=\frac{2 \tilde{j}}{x}-g x
$$

$\widetilde{j}$ is the current within the radius $x$
Current $\widetilde{j}$ is preserved if slice motion is perfectly laminar. The condition of laminarity

$$
\left(1-\frac{x}{2 \tilde{j}} / \frac{d x}{\widetilde{d j}}\right)^{2}+\frac{x^{2}}{4 \tilde{j}}\left(\frac{d x^{\prime}}{\tilde{d} \tilde{j}} / \frac{d x}{\widetilde{d j}}-\frac{x^{\prime}}{x}\right)^{2}<\frac{1}{2}
$$

In a Gaussian slice, it is violated only for $12 \%$ of particles in the halo.

The linearized equation for a small dimensionless deviation from the principal trajectory

$$
\delta^{\prime \prime}+\left(2 \frac{x^{\prime}}{x}+\frac{(\beta \gamma)^{\prime}}{\beta \gamma}\right) \delta^{\prime}=-\frac{4 \widetilde{j}}{x^{2}} \delta
$$

The definition of phase is the same.

Although phase portraits in this case are bent and straightened, but not spread and aligned, the conditions of emittance minima are the same.

## Slice motion in an optimal homogeneous beamline


$\sigma_{0}=1, \sigma_{0}{ }^{\prime}=0, g=0.38, j=1$. The emittance and the rms size of a Gaussian slice.

## Effects and beamlines

- Effect of longitudinal inhomogeneity.
- Effect of transverse inhomogeneity.
- Combined effect.
- Uniform beamline: the focusing is matched to one of the slices.
- Simplest nonuniform beamline: empty space + thin lens + empty space.
- Matched focusing beamline with bunching. $g \propto j$
- Matched focusing beamline with accelerating. $g \propto(\beta \gamma)^{-3}$
- Always: $x_{0}=1, x_{0}{ }^{\prime}=0, j=1$


## Parameters of optimal beamlines

| Parameter | Uniform beamline |  |  |
| :---: | :---: | :---: | :---: |
|  | Longitudinal <br> inhomogeneity | Transverse <br> inhomogeneity | Combined <br> effect |
| $\varepsilon^{\mathrm{c}}$ | 0.023 | 0.0079 | 0.037 |
| $g^{\mathrm{c}}$ | 0.09 | 0.38 | 0.13 |
| $L^{\mathrm{c}}$ | 14.2 | 7.15 | 11.85 |
| Simplest nonuniform beamline |  |  |  |
| $\varepsilon^{\mathrm{c}}$ | 0.030 | 0.0144 | 0.0461 |
| $D^{\mathrm{c}}$ | 0.381 | 0.688 | 0.445 |
| $L^{\mathrm{c}}$ | 14.0 | 8.0 | 12.0 |
| Distributed focusing: bunching |  |  |  |
| $\varepsilon^{\mathrm{c}}$ | $0.0215 \cdot \sqrt[3]{v}$ |  | $0.0349 \cdot v^{0.28}$ |
| $g^{\mathrm{c}}$ | $0.08 \ldots 0.11$ |  | $0.10 \ldots .0 .14$ |
| $L^{\mathrm{c}}$ | $15.7 / \sqrt[3]{v}$ |  | $12.7 \cdot v^{-0.28}$ |
| Distributed focusing: accelerationg |  |  |  |
| $\varepsilon^{\mathrm{c}}$ | $0.0220 \cdot \alpha^{-0.136}$ |  | 0.035 |
| $g^{\mathrm{c}}$ | $0.1 \ldots . .0 .16$ |  | $0.115 \cdot \alpha^{0.227}$ |
| $L^{\mathrm{c}}$ | $11.96+6.05 \alpha$ |  | $10.89+5.03 \alpha$ |

## Emittance

$$
\varepsilon_{n} \cong \varepsilon^{\mathrm{c}} \times \sqrt{\frac{|I|}{I_{0} \beta \gamma}}
$$

Length of beamline

$$
L \cong L^{c} X / \sqrt{\frac{|I|}{I_{0}(\beta \gamma)^{3}}}
$$

## Focusing

$$
g \cong \frac{g^{c}}{x^{2}} \frac{|I|}{I_{0}(\beta \gamma)^{3}}
$$

Lens strength

$$
D \cong \frac{D^{c}}{x} \sqrt{\frac{|I|}{I_{0}(\beta \gamma)^{3}}}
$$

## Emittance at the end of beamline vs its

length $L$ and focusing $g$


## Emittance at the end of beamline vs its length $L$ and focusing $g$ : bunching 10/1



## Normalized emittance at the end of beamline vs its length $L$ and focusing $g$ : accelerating 5/1



## Electron guns

- Strongest space charge effect
- Violation of the model:
- Metallic electrodes near the cathode $\rightarrow$ induced charge
- An area always exists, where $l \gamma<\sigma$
- The head and the tail are in different conditions $\rightarrow$ the gained transverse momentum depends not only on the current, but also on the position in the bunch
- At the same time, in nonrelativistic approximation

$$
\frac{\varepsilon}{r_{e} \sqrt{j}}=\text { const }
$$

- The coefficient is to be found numerically


## Differential parameters of a beam

- A bunch is an ordered set of slices.
- Smooth dependences of the current $I(\zeta)$, the size $x(\zeta)$ and the tilt $x^{\prime}(\zeta)$ of a slice on the longitudinal coordinate in a bunch $\zeta$.
- Similar for particles in a slice.
- $\rightarrow$ It is possible to define the differential phase and the differential relative amplitude of charge oscillation.
$\varphi=\arctan \frac{\frac{d x^{\prime}}{d \zeta}-\frac{x^{\prime}}{x} \frac{d x}{d \zeta}}{\frac{1}{2 \sqrt{j}} \frac{d j}{d \zeta}-\frac{\sqrt{j}}{x} \frac{d x}{d \zeta}}$


Bunch

$$
\begin{gathered}
\varphi=\arctan \frac{\frac{x^{\prime}}{x}-\frac{d x^{\prime}}{d x}}{\frac{2 \sqrt{\widetilde{j}}}{x}-\frac{1}{\sqrt{\tilde{j}}} \cdot \frac{\widetilde{d}}{d x}} \\
A=\frac{\sqrt{\left(\frac{d x}{\tilde{d j}} \cdot \frac{\widetilde{j}}{x}-\frac{1}{2}\right)^{2}+\frac{\widetilde{j}}{4}\left(\frac{d x^{\prime}}{\widetilde{d j}}-\frac{d x}{\widetilde{d j}} \cdot \frac{x^{\prime}}{x}\right)^{2}}}{\frac{d x_{e}}{\widetilde{d j}} \cdot \frac{\widetilde{j}}{x_{e}}-\frac{1}{2}}
\end{gathered}
$$

Slice

## Simulation of guns



Geometry of a gun


The rms size, the tilt, and the emittance of a slice vs current.


Differential parameters of a slice vs current: the phase and the relative amplitude of charge oscillation.

- The phase of charge oscillation in a slice has no pronounced plateau.
- Its relative amplitude is small enough.
- Simultaneous compensation of the effect of longitudinal inhomogeneity and the effect of transverse one is impossible.
- It is not necessary, as the latter is much more weak.


## Simulation of guns



The emittance, mm•mrad, of a 2.2 A peak current bunch vs charge phase advance in the beamline and the current of the matched slice.


The emittance (solid) and the quality factor (dashed) vs the peak current of a bunch: blue for the exit of the gun, red for the optimal ideal beamline, and green for the optimal nonuniform beamline.

## Parameters of model guns

| Gun | $\varepsilon_{0}^{c}$ | $\varepsilon_{h}^{c}$ | $I_{\mathrm{m}} / I_{\mathrm{p}}$ | $\varphi$ | $\varepsilon_{r}^{c}$ |
| :--- | :--- | :--- | :--- | :--- | :--- |
| 300kvGun | $0.25 \ldots 0.35$ | $0.04 \ldots 0.06$ | $0.4 \ldots 0.5$ | $2.4 \ldots 2.5$ | $0.05 \ldots 0.08$ |
| 150 kvGun | $0.25 \ldots 0.35$ | $0.03 \ldots 0.05$ | $0.37 \ldots 045$ | $2.0 \ldots 2.1$ | $0.04 \ldots 0.06$ |
| 300kvShortGun | $0.3 \ldots 0.4$ | $0.04 \ldots 0.07$ | $0.56 \ldots 0.67$ | 1.9 | $0.1 \ldots 0.2$ |
| 850kvGun | $0.35 \ldots 0.5$ | $0.07 \ldots 0.1$ | $0.49 \ldots 0.59$ | $2.5 \ldots 2.7$ | $0.11 \ldots 0.17$ |
| 300kvLongGun | 0.26 | $0.045 \ldots 0.055$ | $0.3 \ldots 0.45$ | $3.1 \ldots 3.4$ | $0.05 \ldots 0.08$ |
| 300kvLongGunPl | $0.3 \ldots 0.5$ | $0.06 \ldots 0.08$ | $0.11 \ldots 0.13$ | $1.6 \ldots 1.8$ | $0.02 \ldots 0.025$ |
| RFGun1MV | $0.2 \ldots 0.35$ | $0.037 \ldots 0.06$ | $0.022 \ldots 0.067$ | $0.6 \ldots 1.0$ | $0.017 \ldots 0.023$ |
| RFGun2MV | $0.2 \ldots 0.35$ | $0.037 \ldots 0.065$ | $0.02 \ldots 0.08$ | $0.6 \ldots 1.1$ | $0.018 \ldots 0.022$ |

- The emittance estimation is the same as for beamlines:

$$
\varepsilon_{n} \cong \varepsilon^{\mathrm{c}} x \sqrt{\frac{|I|}{I_{0} \beta \gamma}}
$$

- Adding of an optimal beamline decreases the emittance by $2 \ldots 15$ times.
- A planar cathode electrode gives better emittance for a pulsed gun than quasi-Pierce geometry.
- The parameters of best existing guns approach the obtained estimation.


## Grid effects

- Scattering on wires.
- Focusing/defocusing in cells at non-optimal current.
- Thinning out of current by cells.
- The second effect is the strongest. It exceeds the macroscopic space charge effect with emittance compensation and can be neglected without the latter.

$$
\varepsilon_{n} \approx 0.01 \frac{\left(r_{e} I\right)^{1 / 3} d}{\sqrt{D}}
$$

$d$ is the cell size,
$D$ is the cathode-to-grid distance,
0.01 is the dimensional coefficient, all the values are in meters and Amps.

## Conclusions

- A principal trajectory is an arbitrary solution of the motion equation.
- The linearized equation for dimensionless deviation from the principal trajectory reveals all the basic properties of the model.
- Charge oscillation is oscillation of deviation from the principal trajectory.
- Its coherence leads to emittance oscillation.
- Conditions of emittance minima: (1) ${ }^{\text {тм' }}=0$ or (2) $\varphi=n \pi$.
- Nonlinearity of charge oscillation $\rightarrow$ violation of coherence $\rightarrow$ residual emittance.
- The scaling formulae for residual emittance and parameters of optimal beamlines are universal, for guns too.
- The parameters of best existing injectors approach the obtained estimation.


